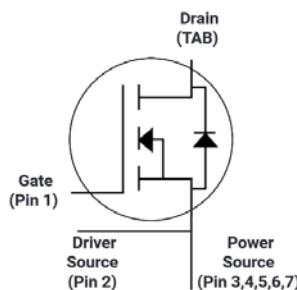


**Silicon Carbide Power MOSFET (N-Channel Enhancement)**

$V_{DS}$	1200V
$I_D$ (25°C)	42A
$R_{DS(on)}$	60mΩ

**Features**

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free,

**Typical Applications**

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

**Mechanical Data**

- **Package:** TO263-7L
- **Terminals:** Tin plated leads
- **Polarity:** As marked

**■Maximum Ratings ( $T_c=25^\circ\text{C}$  Unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	VALUE	TEST CONDITIONS	NOTE
Device marking code				D212060B7GH	
Drain source voltage @ $T_j=25^\circ\text{C}$	$V_{DS,max}$	V	1200	$V_{GS}=0\text{ V}$ , $I_D=100\mu\text{A}$	
Gate source voltage @ $T_j=25^\circ\text{C}$	$V_{GS,max}$	V	-10/+25	Absolute maximum values (AC f > 1Hz, duty cycle < 1%)	
Gate source voltage @ $T_j=25^\circ\text{C}$	$V_{GS,op}$	V	-5/+20	Recommended operational values	
Continuous drain current @ $T_c=25^\circ\text{C}$	$I_D$	A	42	$V_{GS}=20\text{V}$ , $T_c=25^\circ\text{C}$	Fig.14
Continuous drain current @ $T_c=110^\circ\text{C}$			29	$V_{GS}=20\text{V}$ , $T_c=110^\circ\text{C}$	
Pulsed drain current	$I_{D(pulsed)}$	A	88.5	Pulse width tp limited by $T_j,\text{max}$	Fig.15
Avalanche energy, Single Pulse	$E_{AS}$	mJ	400	$V_{DD}=75\text{V}$ , $L=30\text{mH}$	
Power Dissipation	$P_{TOT}$	W	234	$T_c=25^\circ\text{C}$ , $T_j = 175^\circ\text{C}$	Fig.13
Operating junction and Storage temperature range	$T_j, T_{stg}$	°C	-55 to +175		
Soldering temperature	$T_L$	°C	260	1.6mm (0.063") from case for 10s	

## ■ Static Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Gate threshold voltage	V <sub>GS(th)</sub>	V	1.5	2.8	4.0	V <sub>DS</sub> =10V, I <sub>D</sub> = 20mA	Fig.4, 11
Drain source breakdown voltage	V <sub>(BR)DSS</sub>	V	1200			V <sub>GS</sub> =0V, I <sub>D</sub> =100uA	
Zero gate voltage drain current	I <sub>DSS</sub>	uA		<1	50	V <sub>DS</sub> =1200V, V <sub>GS</sub> = 0V	
				10	500	V <sub>DS</sub> =1200V, V <sub>GS</sub> = 0V, Tj= 175°C	
Gate source leakage current	I <sub>GSS</sub>	nA			250	V <sub>GS</sub> = 20V, V <sub>DS</sub> =0V	
Current drain source on-state resistance	R <sub>DS ON</sub>	mΩ		66	80	V <sub>GS</sub> =20V, I <sub>D</sub> =20A	Fig.3, 5, 6
				100		V <sub>GS</sub> =20V, I <sub>D</sub> =20A, Tj=175°C	
Transconductance	g <sub>f</sub>	S		7.7		V <sub>DS</sub> =20V, I <sub>D</sub> =20A	

## ■ Dynamic Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Input capacitance	C <sub>iss</sub>	pF		2200		V <sub>DS</sub> =800V, V <sub>GS</sub> =0V, Tj=25°C, f=1MHz, V <sub>AC</sub> = 25mV	Fig.10
Output capacitance	C <sub>oss</sub>			115			
Reverse capacitance	C <sub>rss</sub>			18.5			
C <sub>oss</sub> stored energy	E <sub>oss</sub>	uJ		47		V <sub>DS</sub> =800V, V <sub>GS</sub> =-5/20V, I <sub>D</sub> =20A	Fig.12
Gate source charge	Q <sub>gs</sub>	nC		29			
Gate drain charge	Q <sub>gd</sub>			64			
Gate charge	Q <sub>g</sub>			129			
Short-Circuit Withstand Time	t <sub>sc</sub>	us		3.6		R <sub>g</sub> =30Ω, I <sub>D</sub> =376A, V <sub>GS</sub> =-5/20V, V <sub>DD</sub> =800V	
Internal Gate Resistance	R <sub>G(int)</sub>	Ω		2.0	5.0	f=1MHz, V <sub>AC</sub> = 25mV	

## ■ Switching Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Turn on delay time	t <sub>d(on)</sub>	ns		5.9		V <sub>DD</sub> =800V, V <sub>GS</sub> =-5/+20V, I <sub>D</sub> =20A, L=100uH, R <sub>G(ext)</sub> = 2.7Ω	Fig.17, 18
Rise time	t <sub>r</sub>			15			
Turn off delay time	t <sub>d(off)</sub>			17.3			
Fall time	t <sub>f</sub>			10			
Turn on switching energy	E <sub>on</sub>			300			
Turn off switching energy	E <sub>off</sub>	uJ		45			

■ **Body diode characteristics** ( $T_c=25^\circ\text{C}$  unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Diode forward voltage	$V_{SD}$	V		4.0		$V_{GS}=0V, I_{SD}=10A$	Fig.8
Continuous diode forward current	$I_s$	A		43		$V_{GS}=0V, T_c=25^\circ\text{C}$	
Reverse recovery time	$t_{rr}$	nS		57			
Reverse recovery charge	$Q_{rr}$	nC		109		$V_{DS}=400V, V_{GS}=0V, I_{SD}=10A, \frac{dI}{dt}=300A/\mu\text{s}$	
Peak reverse recovery current	$I_{rrm}$	A		3.5			

■ **Thermal Characteristics** ( $T_a=25^\circ\text{C}$  Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Value
Thermal resistance	$R_{\theta J-C}$	$^\circ\text{C}/\text{W}$	0.64

■ **Typical Characteristics**

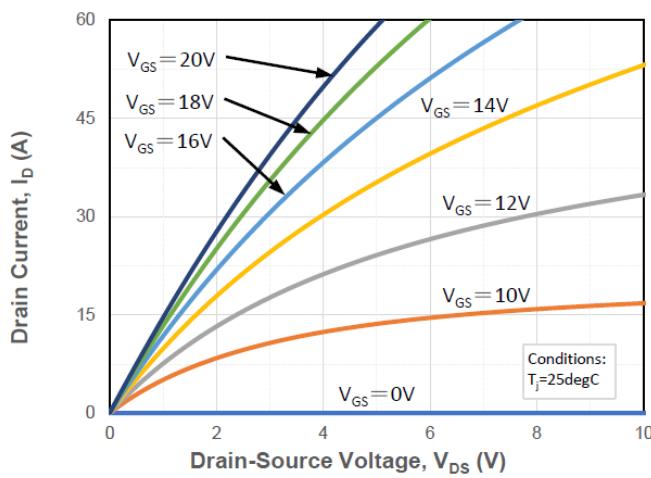


Figure 1. Output Characteristics  $T_j = 25^\circ\text{C}$

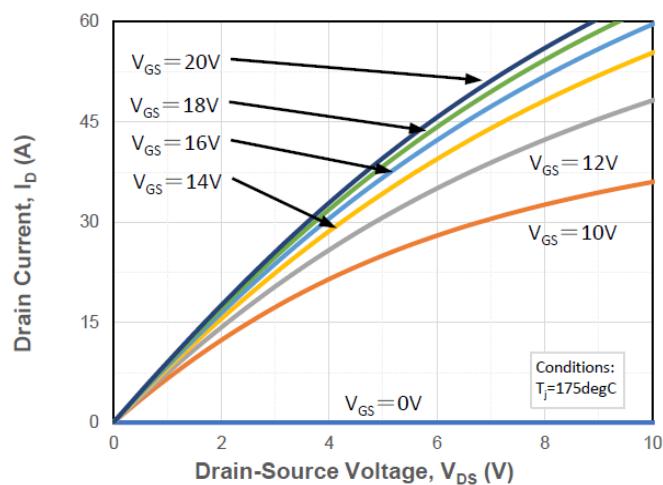


Figure 2. Output Characteristics  $T_j = 175^\circ\text{C}$

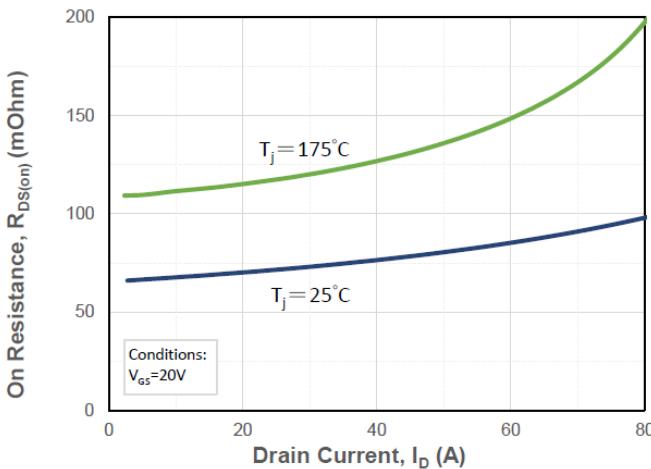


Figure 3. On-resistance vs. drain current

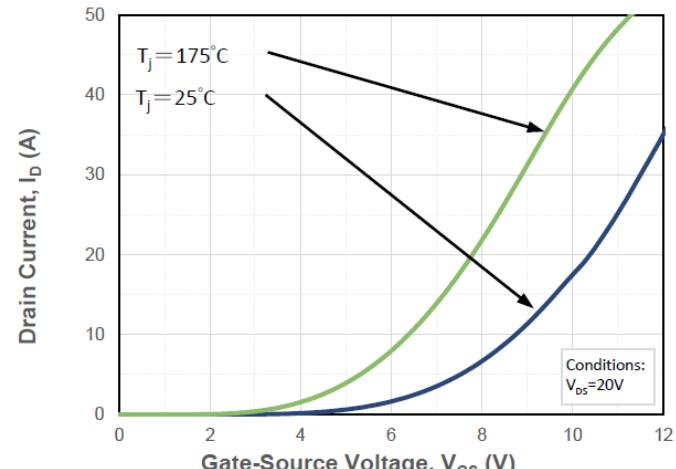


Figure 4. Transfer Characteristics for various  $T_j$

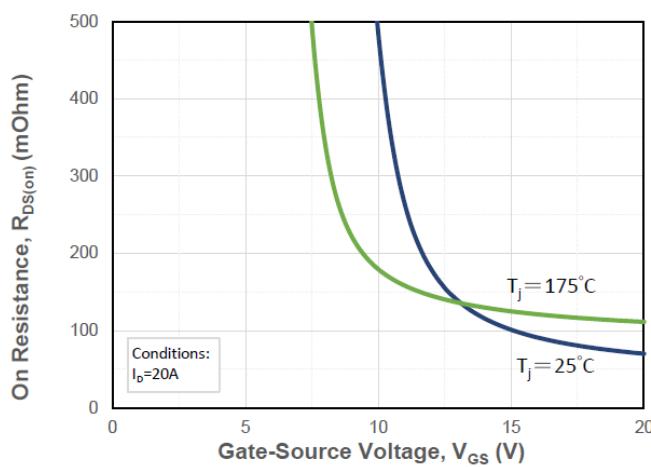


Figure 5. On-resistance vs. gate voltage for various  $T_j$   
Gate voltage

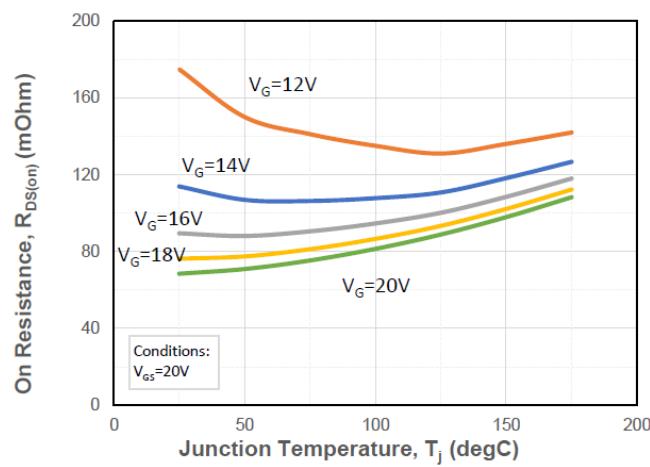


Figure 6. On-resistance vs. Temperature for various

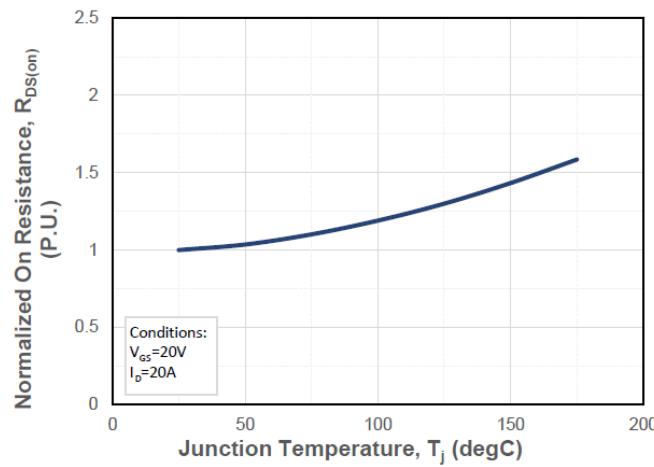


Figure 7. Normalized On-Resistance vs. Temperature

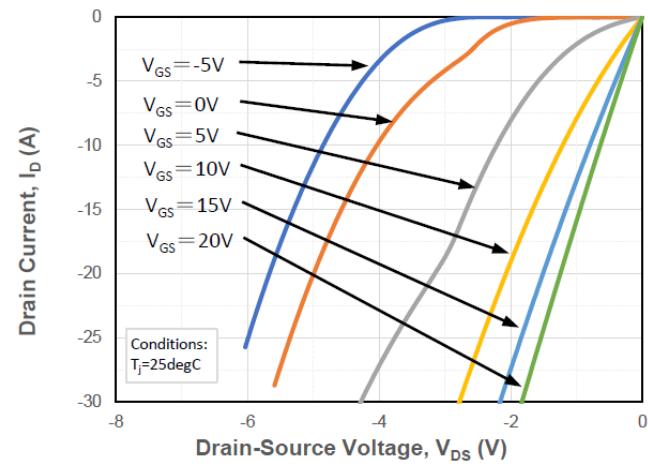


Figure 8. Reverse Output Characteristics at  $T_j = 25^\circ C$

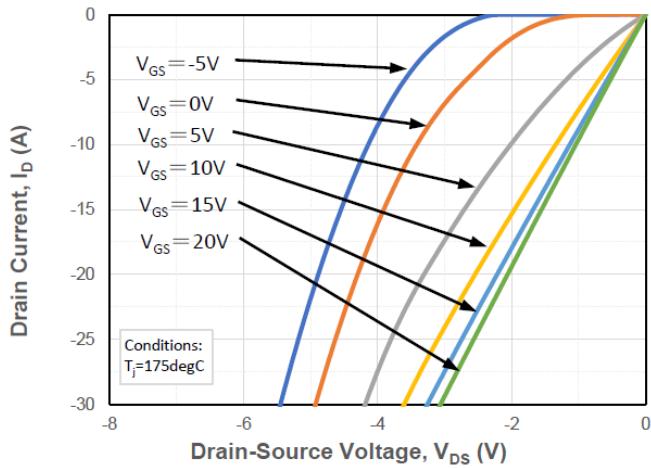


Figure 9. Reverse Output Characteristics at  $T_j = 175^\circ C$

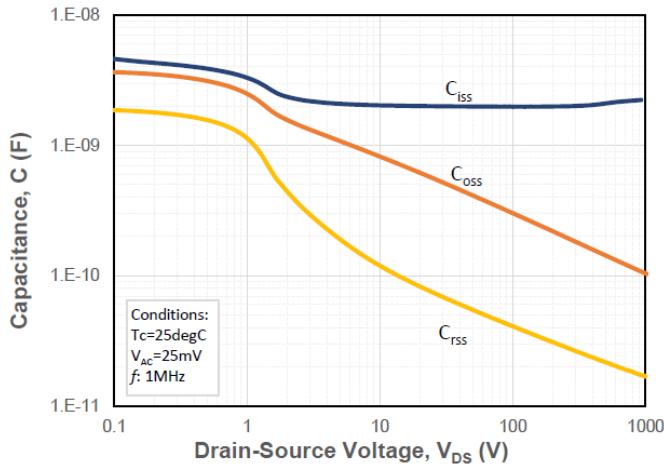


Figure 10. Capacitances vs. Drain to Source Voltage

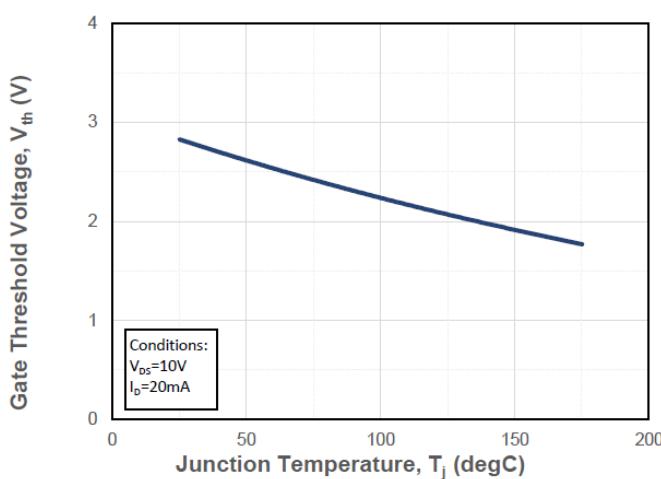


Figure 11. Threshold voltage vs. temperature

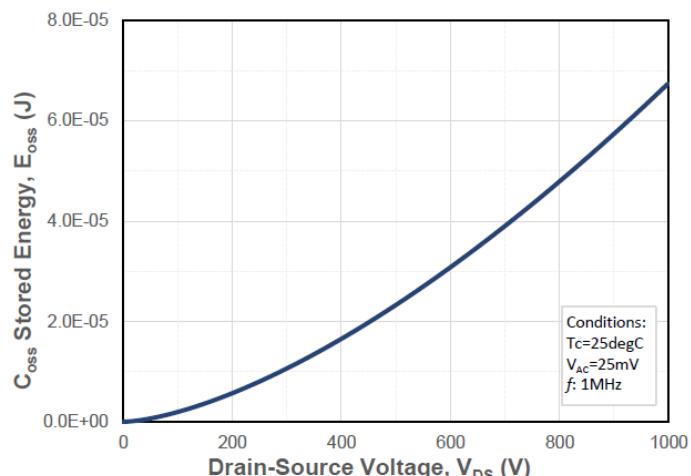


Figure 12. Output Capacitor Stored Energy

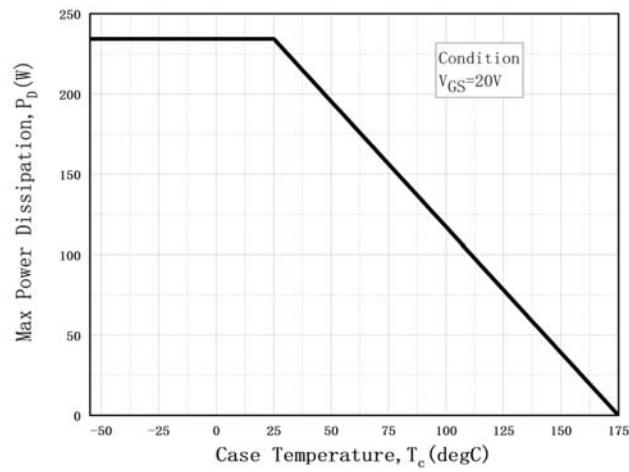


Figure 13. Maximum Power Dissipation Derating vs. Case Temperature

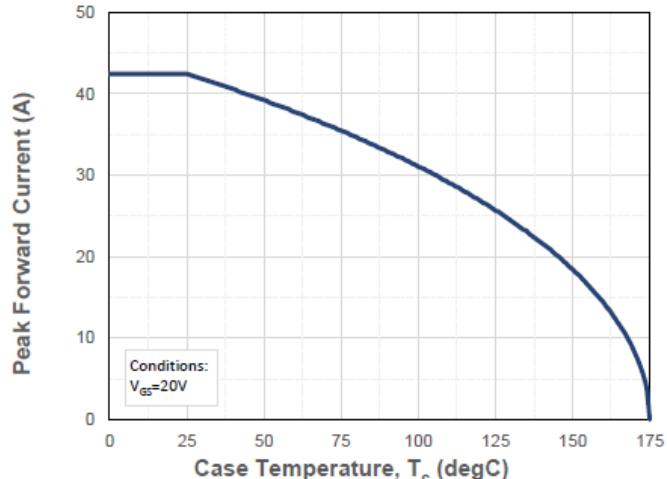


Figure 14. Drain Current Derating vs. Case Temperature

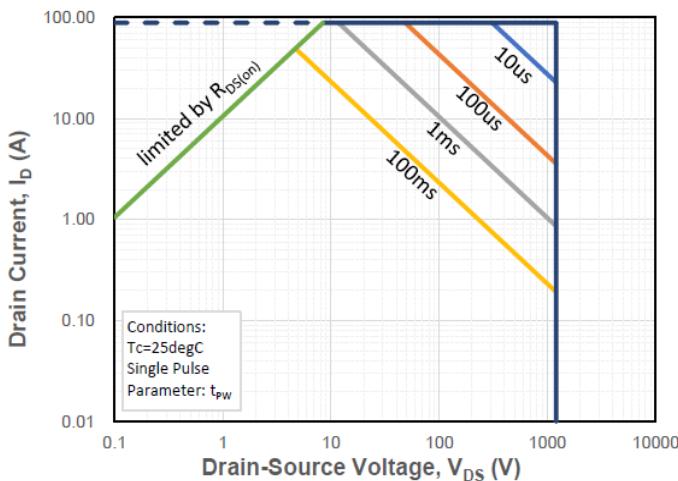


Figure 15. Safe Operating Area

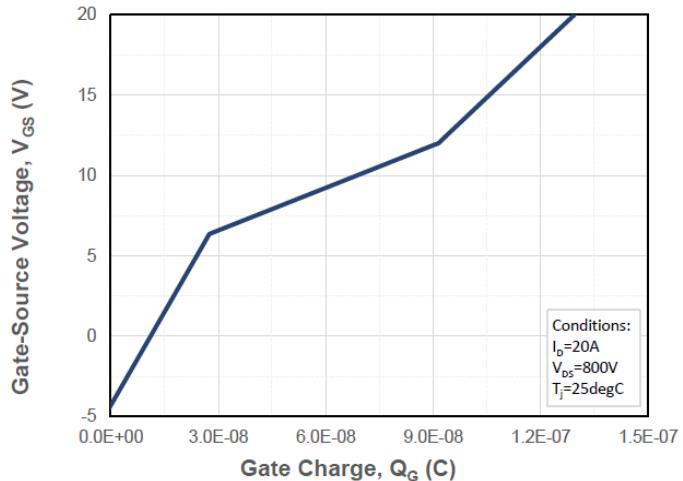


Figure 16. Gate Charge Characteristics

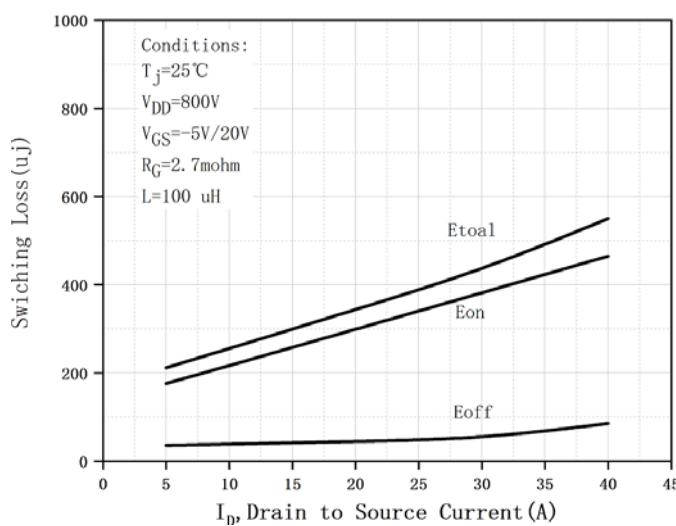


Figure 17. Clamped Inductive Switching Energy vs. Drain Current

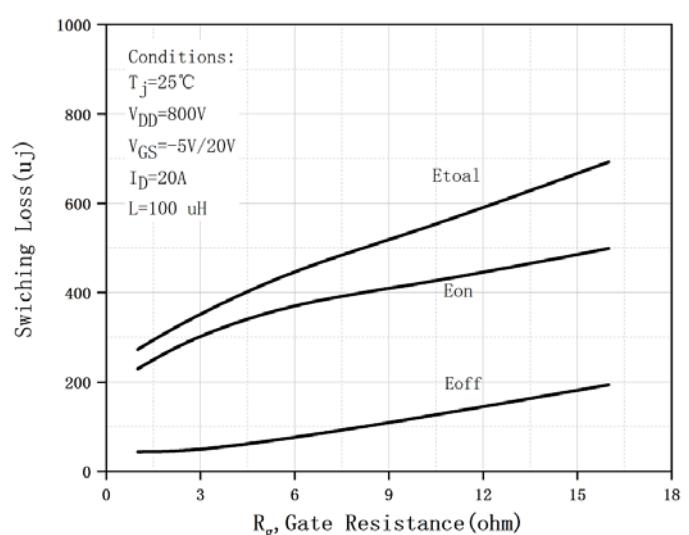


Figure 18. Clamped Inductive Switching Energy vs. External Gate Resistor ( $R_g$ (ext.))

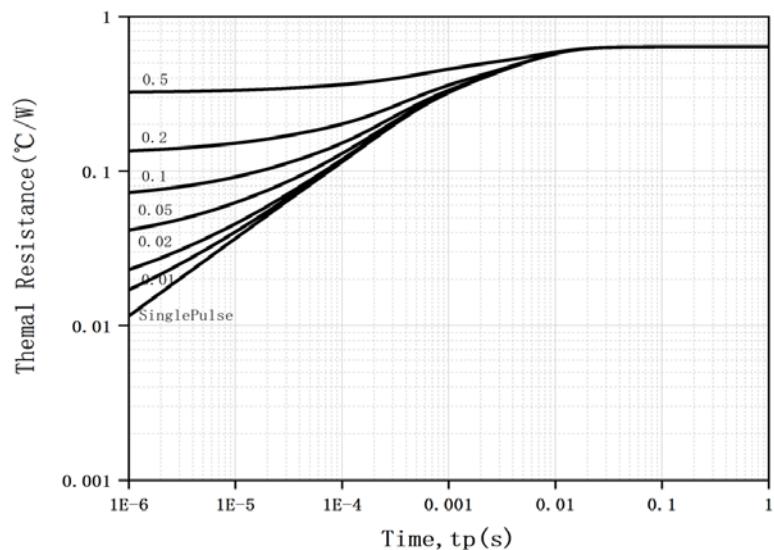


Figure 19. Transient Junction to Case Thermal Impedance

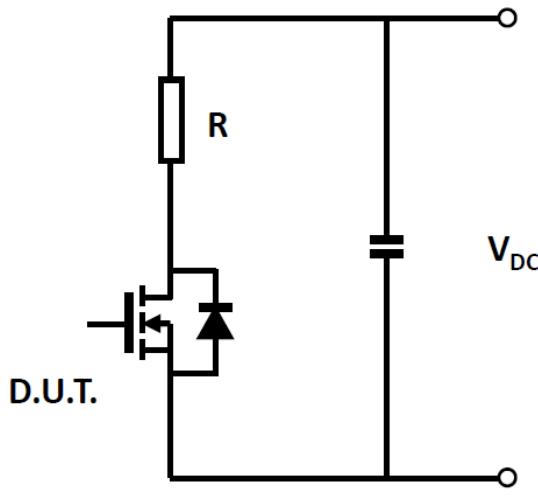


Figure 20. Schematic of Resistive Switching

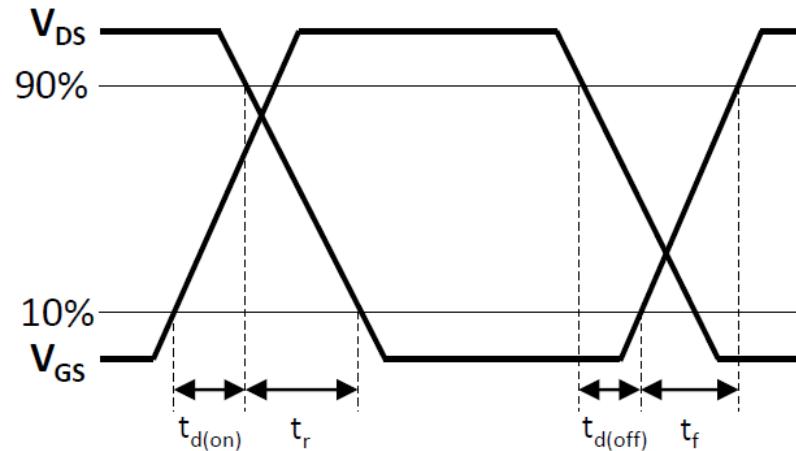
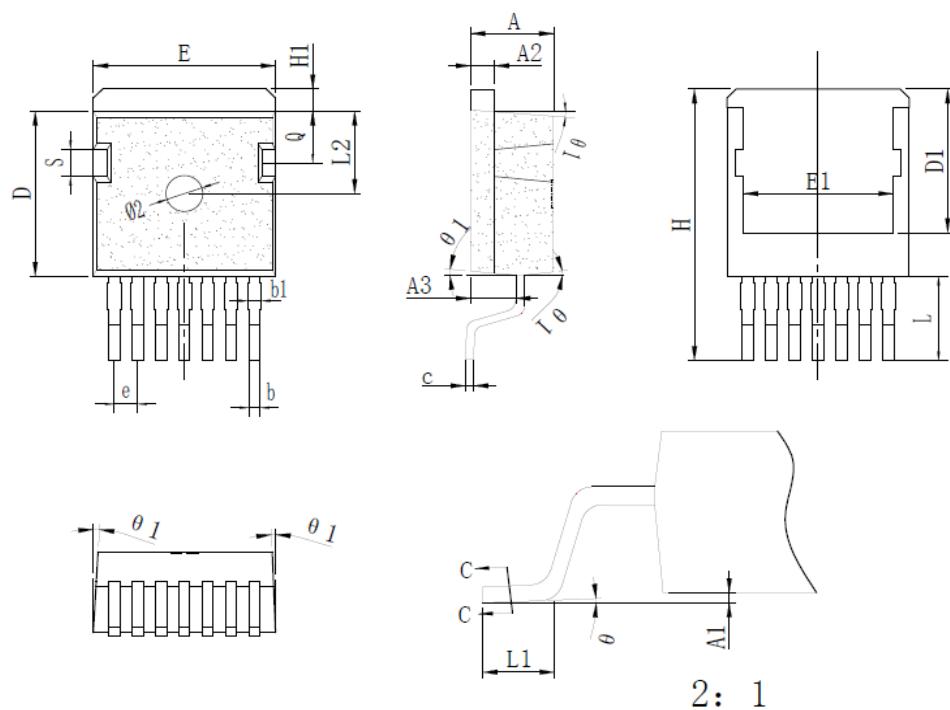
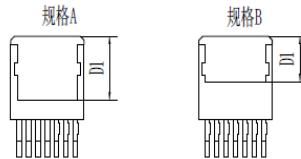


Figure 21. Switching Times Definition

## ■Outline Dimensions



\*为关键管控尺寸



SYMBOL	mm		
	MIN	NOM	MAX
*A	4.30	4.40	4.50
*A1	0.00	0.10	0.20
*A2	1.22	1.27	1.32
*A3	2.30	2.40	2.50
*b	0.50	0.60	0.70
*b1	-	-	0.63
*c	0.45	0.50	0.55
*D	9.15	9.30	9.45
D1	規格A: 8.00REF 規格B: 5.70REF		
*E	10.12	10.16	10.20
E1	8.20	8.40	8.60
*e	1.25	1.27	1.29
*H	14.85	15.00	15.15
H1	1.10	1.20	1.30
*L	4.50	4.70	4.90
L1	1.70	2.00	2.30
L2	4.55	4.65	4.75
S	1.40	1.50	1.60
Q	2.80	2.90	3.00
*θ	0°	2.5°	8°
θ1	5°	7°	9°

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